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FAIRCHILD SEMICONDUCTOR®

December 2013

74LCX07
Low Voltage Hex Buffer with Open Drain Outputs

Features

- 5V tolerant inputs
- 2.3V to 5.5V V_{CC} specifications provided
- 2.9ns t_{PD} max. (V_{CC} = 3.3V), 10µA I_{CC} max.
- Power down high impedance inputs and outputs
- +24mA output drive (V_{CC} = 3.0V)
- Implements proprietary noise/EMI reduction circuitry
- Latch-up performance exceeds JEDEC 78 conditions
- ESD performance:
  - Human body model > 2000V
  - Machine model > 200V
- Leadless DQFN package

General Description

The LCX07 contains six buffers. The inputs tolerate voltages up to 7V allowing the interface of 5V systems to 3V systems.

The outputs of the LCX07 are open drain and can be connected to other open drain outputs to implement active HIGH wire AND or active LOW wire OR functions.

The 74LCX07 is fabricated with advanced CMOS technology to achieve high speed operation while maintaining CMOS low power dissipation.

Ordering Information

Order Number	Package Number	Package Description
74LCX07M	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
74LCX07SJ	M14D	14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74LCX07BQX(1)	MLP14A	14-Terminal Depopulated Quad Very-Thin Flat Pack No Leads (DQFN), JEDEC MO-241, 2.5 x 3.0mm
74LCX07MTC	MTC14	14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide

Note:

1. DQFN package available in Tape and Reel only.

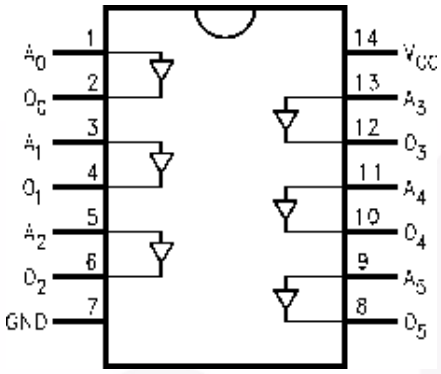
Device also available in Tape and Reel. Specify by appending suffix letter “X” to the ordering number.

All packages are lead free per JEDEC: J-STD-020B standard.

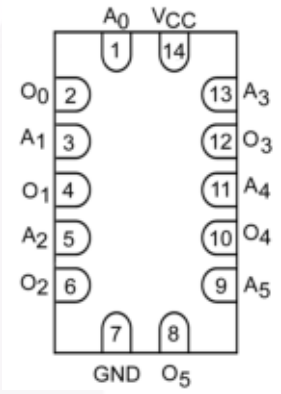
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Connection Diagram

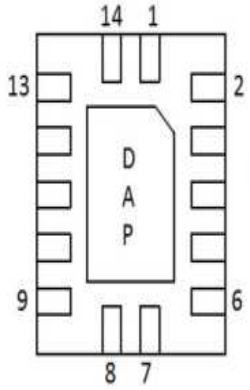
Pin Assignments for SOIC, SOP, and TSSOP



Pad Assignments for DQFN



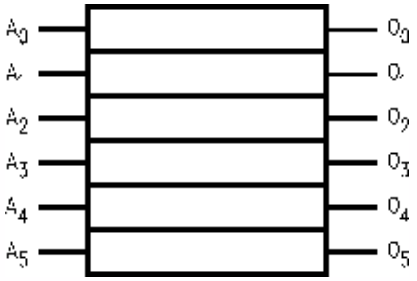
(Top Through View)



(Bottom View)

Logic Symbol

IEEE/IEC



Pin Description

Pin Names	Description
A_n	Inputs
O_n	Outputs
DAP	No Connect

Note: DAP (Die Attach Pad)

Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

Symbol	Parameter	Rating
V_{CC}	Supply Voltage	–0.5V to +7.0V
V_I	DC Input Voltage	–0.5V to +7.0V
V_O	DC Output Voltage, Output in HIGH or LOW State(2)	–0.5V to +7.0V
I_{IK}	DC Input Diode Current, V_I < GND	–50mA
I_{OK}	DC Output Diode Current	
	V_O < GND	–50mA
	V_O > V_{CC}	+50mA
I_O	DC Output Current	±50mA
I_{CC}	DC Supply Current per Supply Pin	±100mA
I_{GND}	DC Ground Current per Ground Pin	±100mA
T_{STG}	Storage Temperature	–65°C to +150°C

Note:

2. I_O Absolute Maximum Rating must be observed.

Recommended Operating Conditions(3)

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. Fairchild does not recommend exceeding them or designing to absolute maximum ratings.

Symbol	Parameter	Min.	Max.	Units
V_{CC}	Supply Voltage			
	Operating	2.0	5.5	V
	Data Retention	1.5	5.5	
V_I	Input Voltage	0	5.5	V
V_O	Output Voltage	0	5.5	V
I_{OL}	Output Current			
	V_{CC} = 4.5V–5.5V		+32	mA
	V_{CC} = 3.0V–3.6V		+24	
	V_{CC} = 2.7V–3.0V		+12	
	V_{CC} = 2.3V–2.7V		+8	
T_A	Free-Air Operating Temperature	–40	85	°C
$\Delta t / \Delta V$	Input Edge Rate, V_{IN} = 0.8V–2.0V, V_{CC} = 3.0V	0	10	ns/V

Note:

3. Unused inputs must be held HIGH or LOW. They may not float.

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DC Electrical Characteristics

Symbol	Parameter	V_{CC} (V)	Conditions	T_A = –40°C to +85°C		Units
				Min.	Max.	
V_{IH}	HIGH Level Input Voltage	2.3–2.7		1.7		V
		2.7–3.6		2.0		
		4.5–5.5		0.7 x V_{CC}		
V_{IL}	LOW Level Input Voltage	2.3–2.7			0.7	V
		2.7–3.6			0.8	
		4.5–5.5			0.3 x V_{CC}	
V_{OL}	LOW Level Output Voltage	2.3–5.5	I_{OL} = 100µA		0.2	V
		2.3	I_{OL} = 8mA		0.6	
		2.7	I_{OL} = 12mA		0.4	
		3.0	I_{OL} = 16mA		0.4	
		3.0	I_{OL} = 24mA		0.55	
		4.5	I_{OL} = 32mA		0.55	
I_I	Input Leakage Current	2.3–5.5	$0 \le V_I \le 5.5V$		±5.0	µA
I_{OFF}	Power-Off Leakage Current	0	V_I or V_O = 5.5V		10	µA
I_{CC}	Quiescent Supply Current	2.3–5.5	$V_I = V_{CC}$ or GND		10	µA
		2.3–5.5	$3.6V \le V_I \le 5.5V$		±10	
ΔI_{CC}	Increase in I_{CC} per Input	2.3–3.6	$V_{IH} = V_{CC} – 0.6V$		500	µA
		4.5–5.5			1	mA
I_{OHZ}	Off State Current	2–5.5	V_O = 5.5V		10	µA

AC Electrical Characteristics

Symbol	Parameter	T_A = –40°C to +85°C, R_L = 500Ω								Units
		V_{CC} = 5.0V ± 0.5V, C_L = 50pF		V_{CC} = 3.3V ± 0.3V, C_L = 50pF		V_{CC} = 2.7V, C_L = 50pF		V_{CC} = 2.5V ± 0.2V, C_L = 30pF		
		Min.	Max.	Min.	Max.	Min	Max	Min	Max	
t_{PZL}, t_{PLZ}	Propagation Delay Time	0.5	3.0	0.8	3.7	1.0	4.4	0.8	3.8	ns

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Dynamic Switching Characteristics

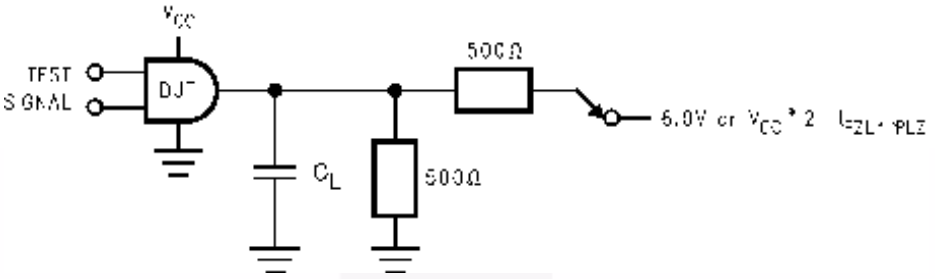
Symbol	Parameter	V_{CC} (V)	Conditions	$T_A = 25°C$ Typical	Unit
V_{OLP}	Quiet Output Dynamic Peak V_{OL}	3.3	$C_L = 50pF$, $V_{IH} = 3.3V$, $V_{IL} = 0V$	0.9	V
		2.5	$C_L = 30pF$, $V_{IH} = 2.5V$, $V_{IL} = 0V$	0.7	
V_{OLV}	Quiet Output Dynamic Valley V_{OL}	3.3	$C_L = 50pF$, $V_{IH} = 3.3V$, $V_{IL} = 0V$	–0.8	V
		2.5	$C_L = 30pF$, $V_{IH} = 2.5V$, $V_{IL} = 0V$	–0.6	

Capacitance

Symbol	Parameter	Conditions	Typical	Units
C_{IN}	Input Capacitance	V_{CC} = Open, $V_I = 0V$ or V_{CC}	7	pF
C_{OUT}	Output Capacitance	$V_{CC} = 3.3V$, $V_I = 0V$ or V_{CC}	8	pF
C_{PD}	Power Dissipation Capacitance	$V_{CC} = 3.3V$, $V_I = 0V$ or V_{CC}, f = 10MHz	25	pF

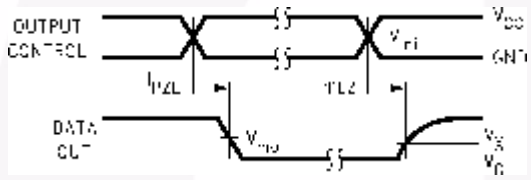
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AC Loading and Waveforms

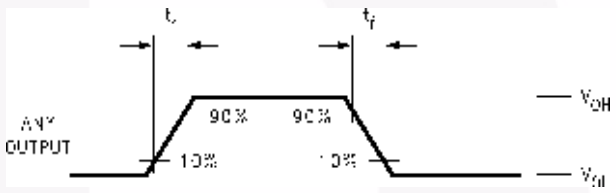


Test	Switch
t_{PZL}, t_{PLZ}	V_{CC} x 2 at V_{CC} = 5.0 ± 0.5V
	6V at V_{CC} = 3.3 ± 0.3V
	V_{CC} x 2 at V_{CC} = 2.5 ± 0.2V

Figure 1. AC Test Circuit (C_L includes probe and jig capacitance)



3-STATE Output Low Enable and Disable Times for Logic



t_{rise} and t_{fall}

Symbol	V_{CC}			
	5.0V ± 0.5V	3.3V ± 0.3V	2.7V	2.5V ± 0.2V
V_{mi}	V_{CC} / 2	1.5V	1.5V	V_{CC} / 2
V_{mo}	V_{CC} / 2	1.5V	1.5V	V_{CC} / 2
V_x	V_{OL} + 0.3V	V_{OL} + 0.3V	V_{OL} + 0.3V	V_{OL} + 0.15V
V_y	V_{OH} – 0.3V	V_{OH} – 0.3V	V_{OH} – 0.3V	V_{OH} – 0.15V

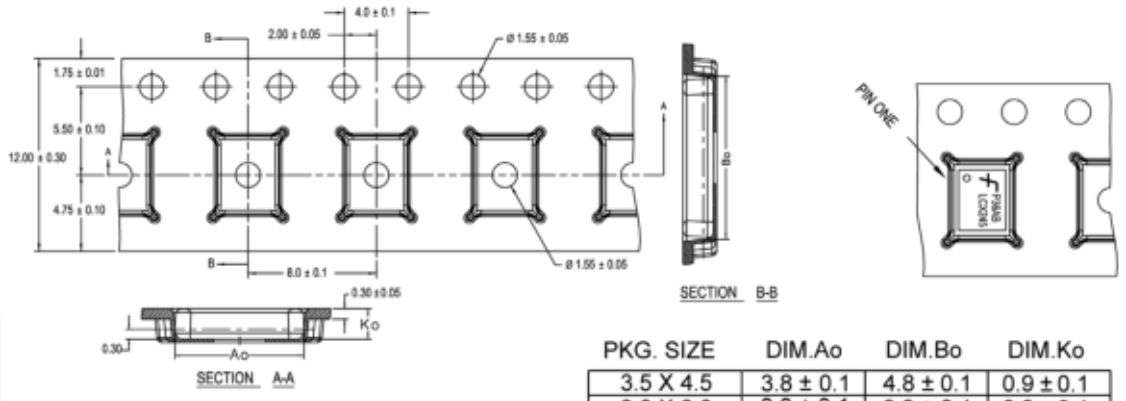
Figure 2. Waveforms (Input Pulse Characteristics; f =1MHz, t_r = t_f = 3ns)

Tape and Reel Specification

Tape Format for DQFN

Package Designator	Tape Section	Number of Cavities	Cavity Status	Cover Tape Status
BQX	Leader (Start End)	125 (Typ.)	Empty	Sealed
	Carrier	3000	Filled	Sealed
	Trailer (Hub End)	75 (Typ.)	Empty	Sealed

Tape Dimensions inches (millimeters)



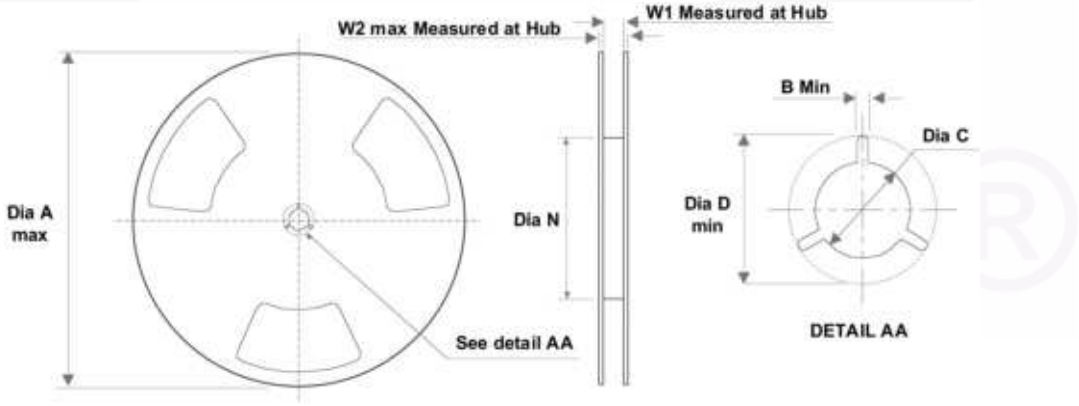
PKG. SIZE	DIM.Ao	DIM.Bo	DIM.Ko
3.5 X 4.5	3.8 ± 0.1	4.8 ± 0.1	0.9 ± 0.1
3.0 X 3.0	3.3 ± 0.1	3.3 ± 0.1	0.9 ± 0.1
2.5 X 4.5	2.8 ± 0.1	4.8 ± 0.1	0.9 ± 0.1
2.5 X 3.5	2.8 ± 0.1	3.8 ± 0.1	0.9 ± 0.1
2.5 X 3.0	2.8 ± 0.1	3.3 ± 0.1	0.9 ± 0.1
2.5 X 2.5	2.8 ± 0.1	2.8 ± 0.1	0.9 ± 0.1

DIMENSIONS ARE IN MILLIMETERS

NOTES: unless otherwise specified

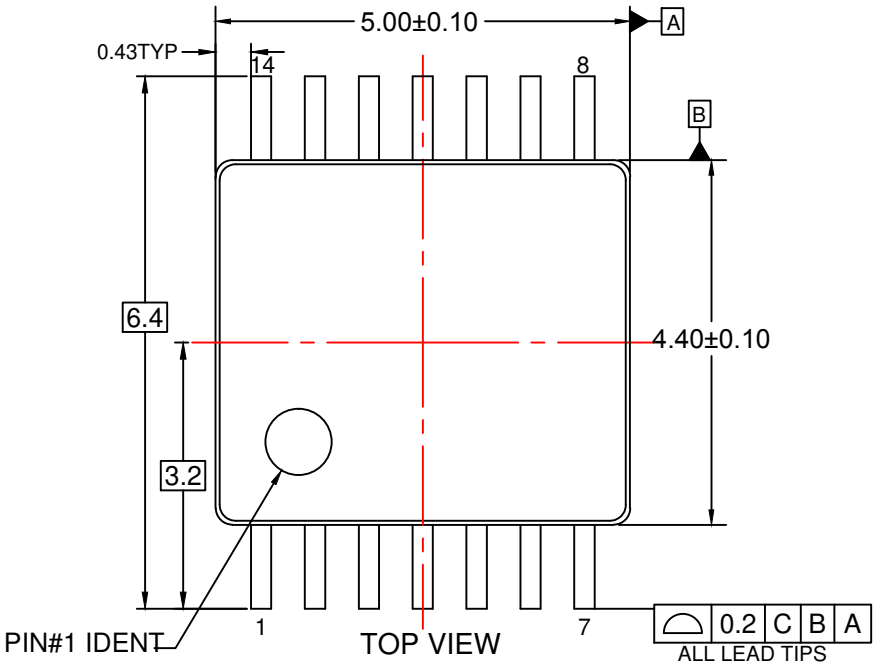
1. Cummulative pitch for feeding holes and cavities (chip pockets) not to exceed 0.008[0.20] over 10 pitch span.
2. Smallest allowable bending radius.
3. Thru hole inside cavity is centered within cavity.
4. Tolerance is ±0.002[0.05] for these dimensions on all 12mm tapes.
5. Ao and Bo measured on a plane 0.120[0.30] above the bottom of the pocket.
6. Ko measured from a plane on the inside bottom of the pocket to the top surface of the carrier.
7. Pocket position relative to sprocket hole measured as true position of pocket. Not pocket hole.
8. Controlling dimension is millimeter. Diemension in inches rounded.

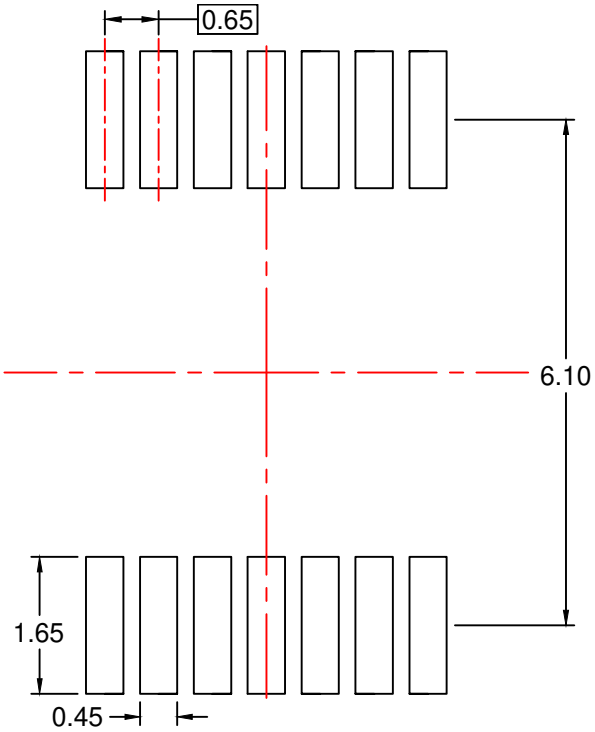
Reel Dimensions inches (millimeters)

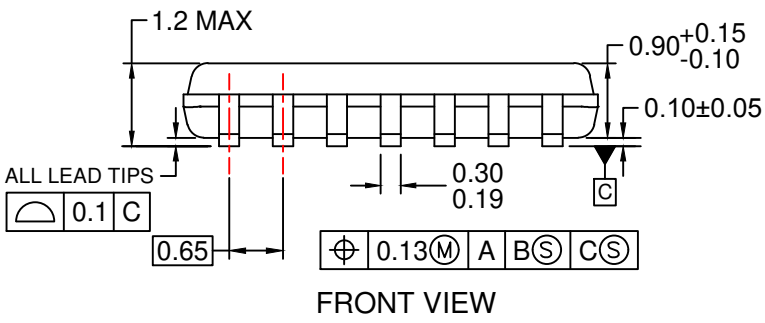


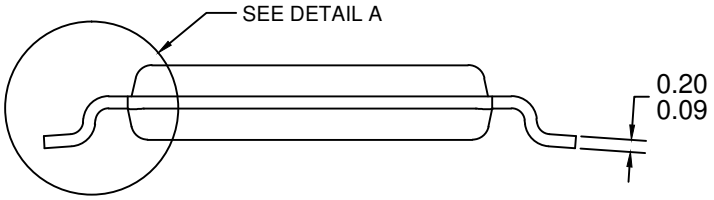
Tape Size	A	B	C	D	N	W1	W2
12mm	13.0 (330.0)	0.059 (1.50)	0.512 (13.00)	0.795 (20.20)	2.165 (55.00)	0.488 (12.4)	0.724 (18.4)

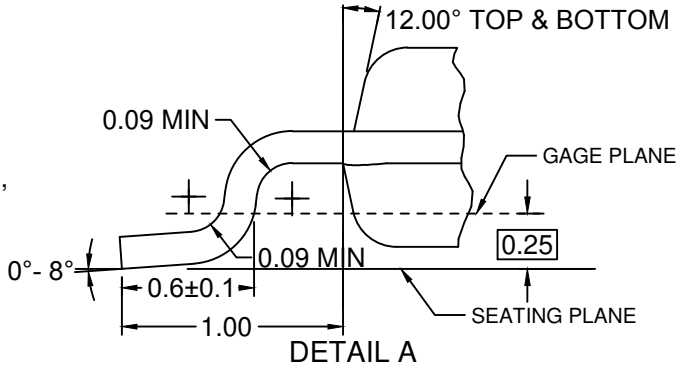
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NOTES:

A. CONFORMS TO JEDEC REGISTRATION MO-153, VARIATION AB, REF NOTE 6

B. DIMENSIONS ARE IN MILLIMETERS.

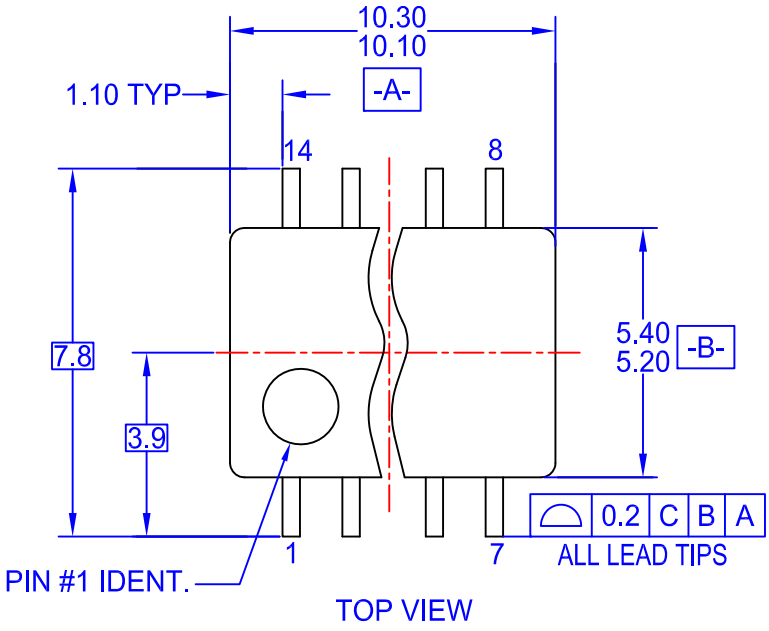
C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS

D. DIMENSIONING AND TOLERANCES PER ANSI Y14.5M, 2009.

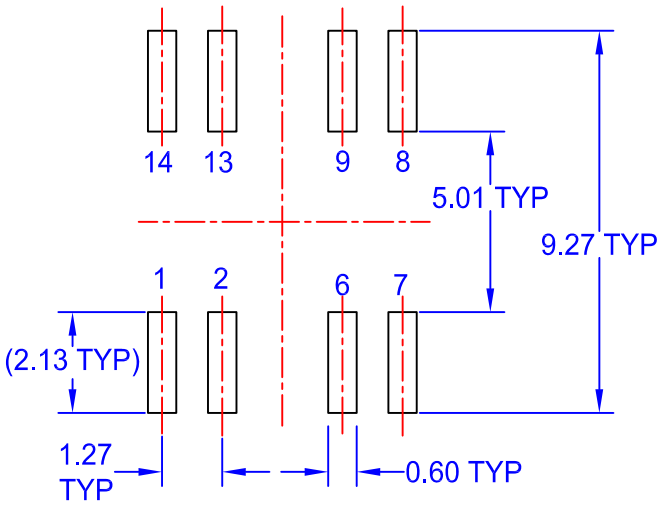
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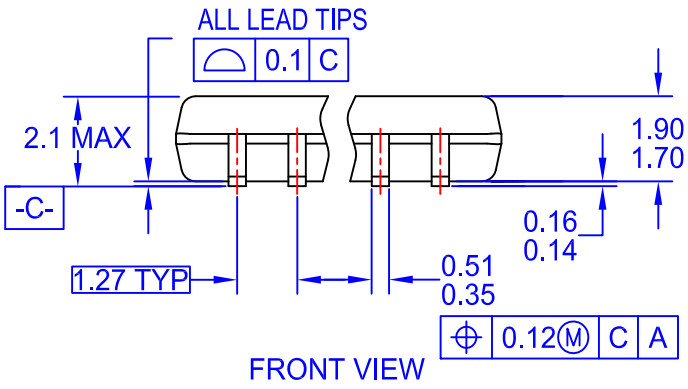
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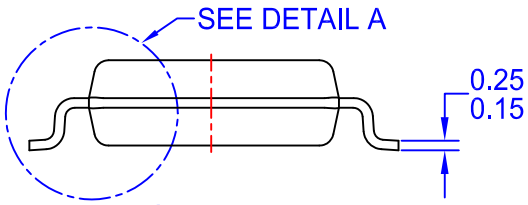
TOP VIEW



LAND PATTERN RECOMMENDATION



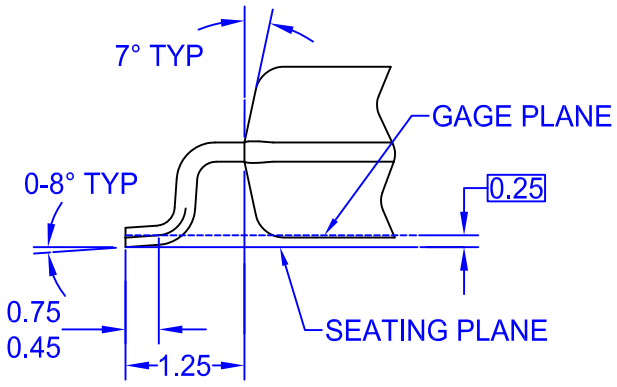
FRONT VIEW



SIDE VIEW

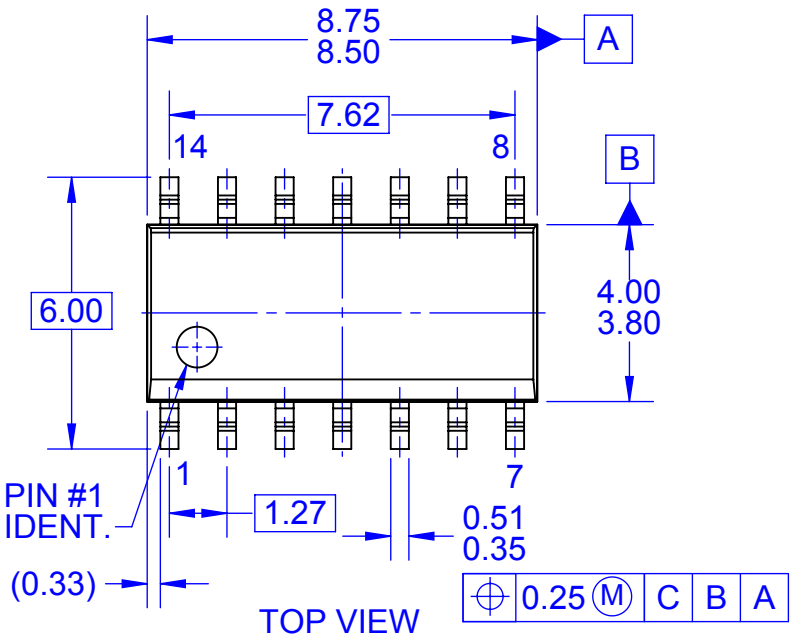
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B. DIMENSIONS ARE IN MILLIMETERS.
C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
D. DRAWING FILENAME: MKT-M14Drev4.

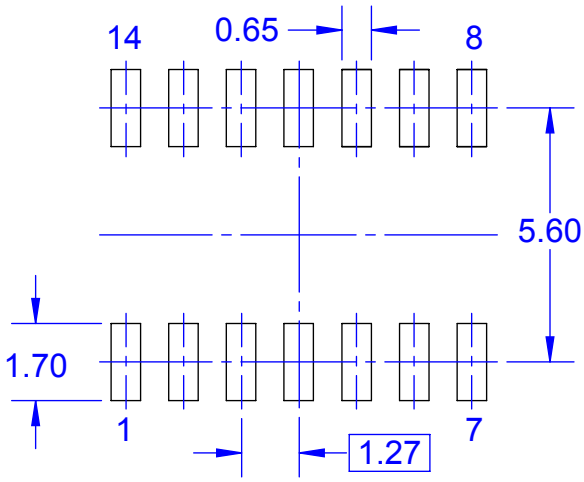


DETAIL A

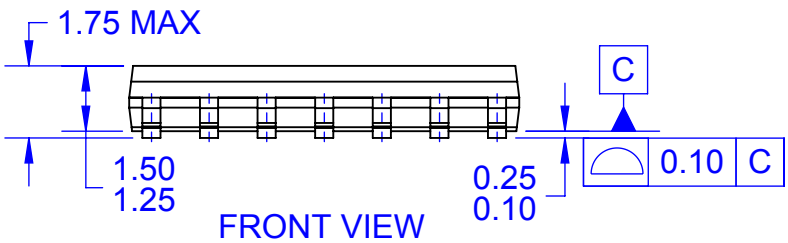
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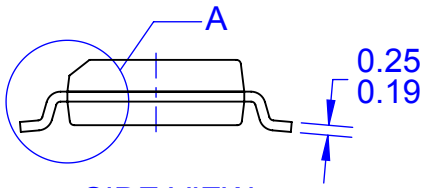
TOP VIEW



LAND PATTERN RECOMMENDATION



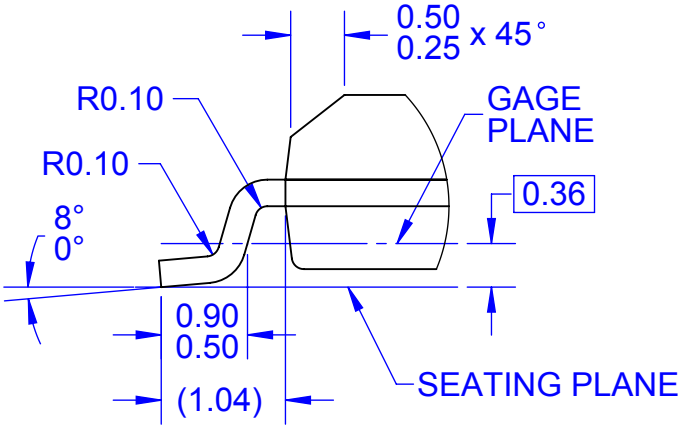
FRONT VIEW



SIDE VIEW

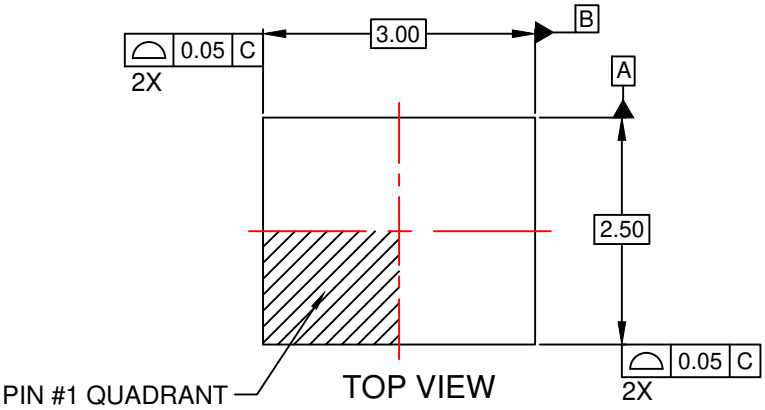
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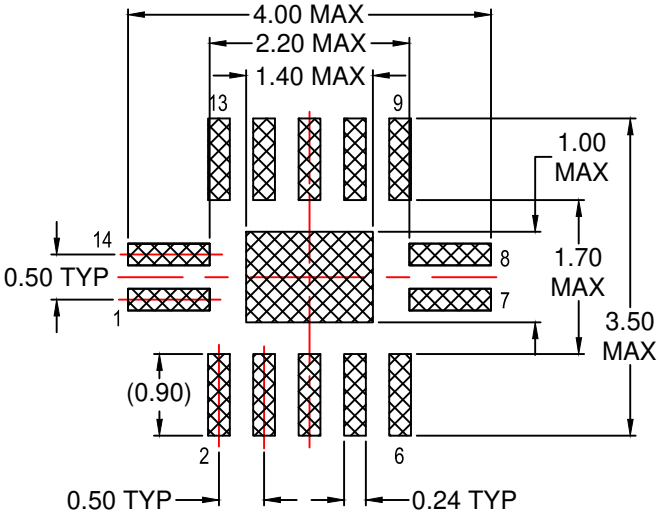
A. CONFORMS TO JEDEC MS-012, VARIATION AB, ISSUE C
B. ALL DIMENSIONS ARE IN MILLIMETERS
C. DIMENSIONS DO NOT INCLUDE MOLD FLASH OR BURRS
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E. CONFORMS TO ASME Y14.5M, 2009
D. DRAWING FILENAME: MKT-M14Arev14



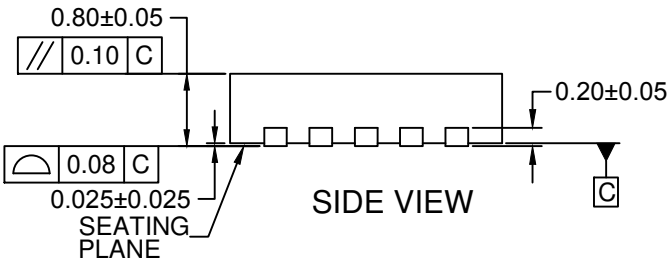
DETAIL A
SCALE 16 : 1

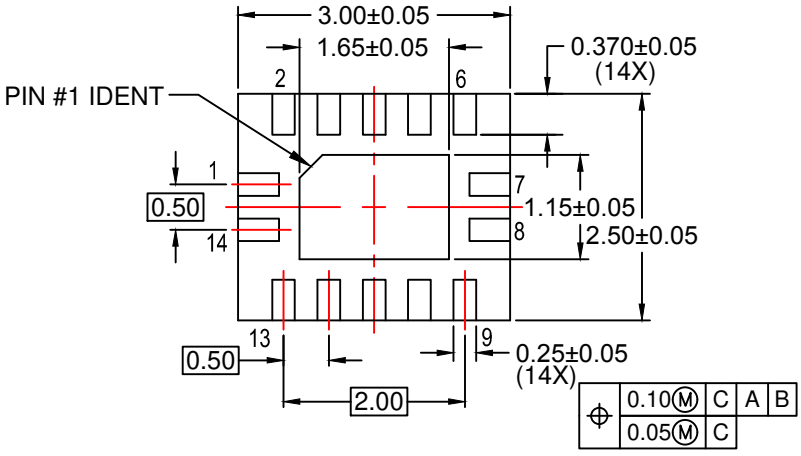
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RECOMMENDED LAND PATTERN





NOTES:

A. CONFORMS TO JEDEC REGISTRATION MO-241, VARIATION AA

B. DIMENSIONS ARE IN MILLIMETERS.

C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.

D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.

E. DRAWING FILENAME: MKT-MLP14Arev2.

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